

Dual N-channel TrenchMOS standard level FET 19 April 2013 Pr

Product data sheet

### 1. General description

Dual standard level N-channel MOSFET in a LFPAK56D package using TrenchMOS technology. This product has been designed and qualified to AEC Q101 standard for use in high performance automotive applications.

### 2. Features and benefits

- Q101 compliant
- Repetitive avalanche rated
- Suitable for thermally demanding environments due to 175 °C rating
- True standard level gate with V<sub>GS(th)</sub> > 1 V @ 175 °C

### 3. Applications

- 12 V Automotive systems
- Motors, lamps and solenoid control
- Start-stop micro-hybrid applications
- Transmission control
- Ultra high performance power switching

### 4. Quick reference data

Table 1. Q	uick reference data					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	-	30	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>mb</sub> = 25 °C; <u>Fig. 1</u>	-	-	40	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	-	-	68	W
Static chara	cteristics FET1 and FET2					
R <sub>DSon</sub>	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 25 °C; <u>Fig. 12</u>	-	4.34	5.1	mΩ
Dynamic ch	aracteristics FET1 and FE	T2				
Q <sub>GD</sub>	gate-drain charge	$I_D = 10 \text{ A}; V_{DS} = 24 \text{ V}; V_{GS} = 10 \text{ V};$ $T_j = 25 \text{ °C}; \underline{Fig. 14}; \underline{Fig. 15}$	-	9	-	nC





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### 5. Pinning information

Table 2.	Pinning	information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source1		D1 D1 D2 D2
2	G1	gate1		
3	S2	source2		
4	G2	gate2	$\bigcirc$	
5	D2	drain2		 S1 G1 S2 G2
6	D2	drain2		mbk725
7	D1	drain1	1 2 3 4 LFPAK56D (SOT1205)	
8	D1	drain1	(0011200)	

## 6. Ordering information

Table 3.Ordering in	formation					
Type number	Package					
	Name	Description	Version			
BUK7K5R1-30E	LFPAK56D	Plastic single ended surface mounted package (LFPAK56D); 8 leads	SOT1205			

### 7. Marking

Table 4. Marking codes	
Type number	Marking code
BUK7K5R1-30E	75E130

### 8. Limiting values

#### Table 5.Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> ≥ 25 °C; T <sub>j</sub> ≤ 175 °C	-	30	V
V <sub>DGR</sub>	drain-gate voltage	$R_{GS}$ = 20 k $\Omega$ ; $T_j \ge 25 \text{ °C}$ ; $T_j \le 175 \text{ °C}$	-	30	V
V <sub>GS</sub>	gate-source voltage	T <sub>j</sub> ≤ 175 °C; DC	-20	20	V
I <sub>D</sub>	drain current	T <sub>mb</sub> = 25 °C; V <sub>GS</sub> = 10 V; <u>Fig. 1</u>	-	40	А
		T <sub>mb</sub> = 100 °C; V <sub>GS</sub> = 10 V; <u>Fig. 1</u>	-	40	А
I <sub>DM</sub>	peak drain current	$T_{mb}$ = 25 °C; pulsed; $t_p \le 10 \ \mu$ s; Fig. 4	-	340	А
P <sub>tot</sub>	total power dissipation	T <sub>mb</sub> = 25 °C; <u>Fig. 2</u>	-	68	W
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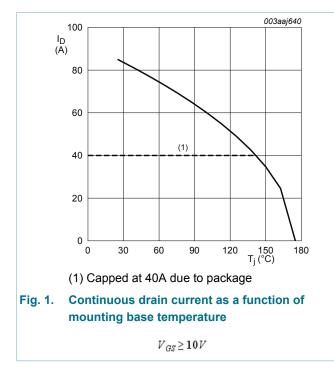
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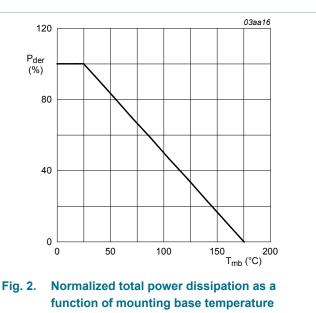
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Symbol	Parameter	Conditions		Min	Мах	Unit		
T <sub>stg</sub>	storage temperature			-55	175	°C		
Tj	junction temperature			-55	175	°C		
T <sub>sld(M)</sub>	peak soldering temperature			-	260	°C		
Source-drain diode FET1 and FET2								
l <sub>S</sub>	source current	T <sub>mb</sub> = 25 °C		-	40	А		
I <sub>SM</sub>	peak source current	pulsed; $t_p \le 10 \ \mu s$ ; $T_{mb} = 25 \ ^\circ C$		-	340	А		
Avalanche Ruggedness FET1 and FET2								
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 40 A; $V_{sup} \le 30$ V; $V_{GS}$ = 10 V; $T_{j(init)}$ = 25 °C; <u>Fig. 3</u>	[1][2]	-	228	mJ		

[1] Refer to application note AN10273 for further information

[2] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C

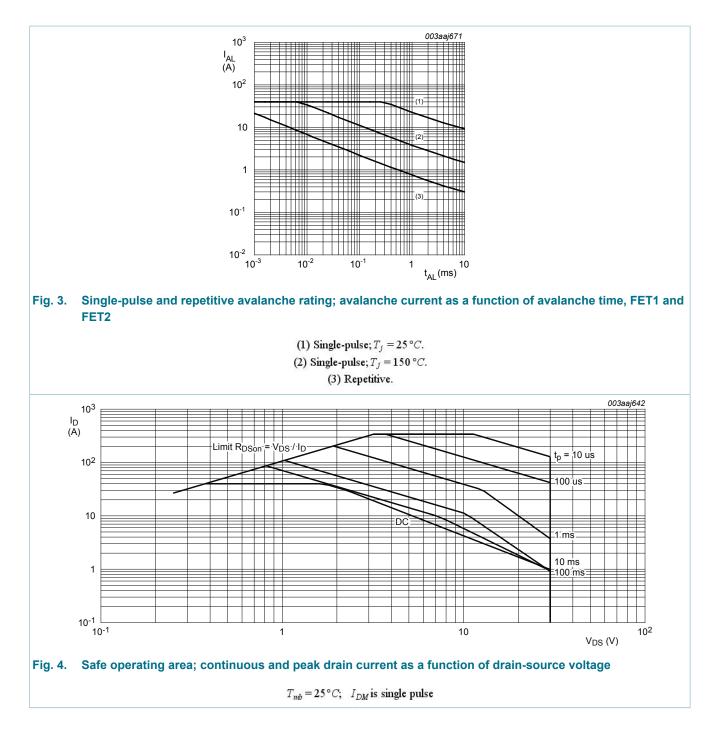




$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100 \%$$

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### 9. Thermal characteristics

Table 6.	Thermal characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-mb)</sub>	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	-	2.21	K/W

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Parameter	Conditions	5			Min	Тур	Мах	Unit
thermal resistance from junction to ambient		Minimum footprint; mounted on a printed circuit board			-		-	K/W
							003aaj584	
2 0.5								
							. t <sub>o</sub>	
ngle shot								
10 <sup>-5</sup>	10 <sup>-4</sup>	10 <sup>-3</sup>	10 <sup>-2</sup>		10 <sup>-1</sup>	I≪— T —►	s) 1	
	thermal resistance from junction to ambient	thermal resistance from junction to ambient 0.5 0.5 0.5 0.5 0.5 0.5 0.5 0.5	thermal resistance from junction to ambient ambient Minimum footprint; mounter printed circuit board ambient	thermal resistance from junction to ambient 0.5 0.5 0.5 0.5 0.5 0.5 0.5 0.5	thermal resistance from junction to ambient Minimum footprint; mounted on a printed circuit board   0.5 0.5   2 0.5   1 0.5   2 0.5   1 0.5	thermal resistance from junction to ambient	thermal resistance from junction to ambient 0.5 2 1 1 5 2 1 1 1 1 1 1 1 1 1 1 1 1 1 1	thermal resistance from junction to ambient Minimum footprint; mounted on a printed circuit board - 95 -   0.5 0.5 0 <

### **10. Characteristics**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics FET1 and FET2	· · ·				
V <sub>(BR)DSS</sub>	drain-source	$I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = -55 °C	27	-	-	V
	breakdown voltage	$I_D$ = 250 µA; $V_{GS}$ = 0 V; $T_j$ = 25 °C	30	-	-	V
V <sub>GS(th)</sub>	gate-source threshold voltage	I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 25 °C; Fig. 10; Fig. 11	2.4	3	4	V
		I <sub>D</sub> = 1 mA; V <sub>DS</sub> = V <sub>GS</sub> ; T <sub>j</sub> = 175 °C; Fig. 10; Fig. 11	1	-	-	V
		$I_D$ = 1 mA; $V_{DS}$ = $V_{GS}$ ; $T_j$ = -55 °C; Fig. 10; Fig. 11	-	-	4.5	V
I <sub>DSS</sub>	drain leakage current	$V_{DS}$ = 30 V; $V_{GS}$ = 0 V; $T_j$ = 175 °C	-	-	500	μA
		$V_{DS}$ = 30 V; $V_{GS}$ = 0 V; $T_j$ = 25 °C	-	0.02	1	μA
I <sub>GSS</sub>	gate leakage current	$V_{GS}$ = -20 V; $V_{DS}$ = 0 V; $T_j$ = 25 °C	-	2	100	nA
		V <sub>GS</sub> = 20 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	2	100	nA
Doon	drain-source on-state resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 25 °C; Fig. 12	-	4.34	5.1	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 175 °C; Fig. 12; Fig. 13	-	7.6	9.4	mΩ

### **Dual N-channel TrenchMOS standard level FET**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Dynamic cl	naracteristics FET1 and FE	T2				
Q <sub>G(tot)</sub>	total gate charge	$I_D$ = 10 A; $V_{DS}$ = 24 V; $V_{GS}$ = 10 V;	-	31.1	-	nC
Q <sub>GS</sub>	gate-source charge	T <sub>j</sub> = 25 °C; <u>Fig. 14; Fig. 15</u>	-	7.6	-	nC
Q <sub>GD</sub>	gate-drain charge		-	9	-	nC
C <sub>iss</sub>	input capacitance	V <sub>GS</sub> = 0 V; V <sub>DS</sub> = 25 V; f = 1 MHz; T <sub>j</sub> = 25 °C; <u>Fig. 16</u>	-	1764	2352	pF
C <sub>oss</sub>	output capacitance		-	422	506	pF
C <sub>rss</sub>	reverse transfer capacitance		-	242	332	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 24 V; R <sub>L</sub> = 2.4 Ω; V <sub>GS</sub> = 10 V;	-	9.5	-	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 5 \Omega; T_j = 25 °C; I_D = 10 A$	-	12.5	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	19.5	-	ns
t <sub>f</sub>	fall time	-	-	13	-	ns
Source-dra	in diode FET1 and FET2					
V <sub>SD</sub>	source-drain voltage	$I_{\rm S}$ = 10 A; $V_{\rm GS}$ = 0 V; $T_{\rm j}$ = 25 °C; Fig. 17	-	0.78	1.2	V
t <sub>rr</sub>	reverse recovery time	$I_{S}$ = 10 A; dI <sub>S</sub> /dt = -100 A/µs; V <sub>GS</sub> = 0 V;	-	27.4	-	ns
Q <sub>r</sub>	recovered charge	V <sub>DS</sub> = 15 V; T <sub>j</sub> = 25 °C	-	20.7	-	nC

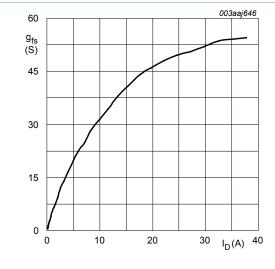
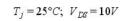


Fig. 6. Forward transconductance as a function of drain current; typical values



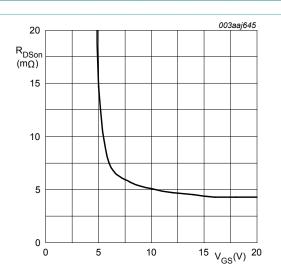
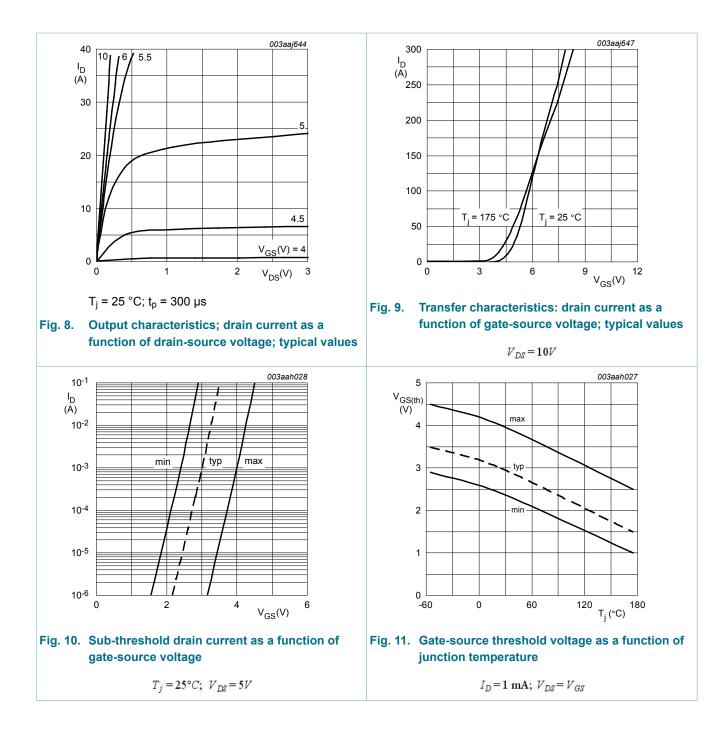


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

 $T_j = 25^{\circ}C; I_D = 10A$ 

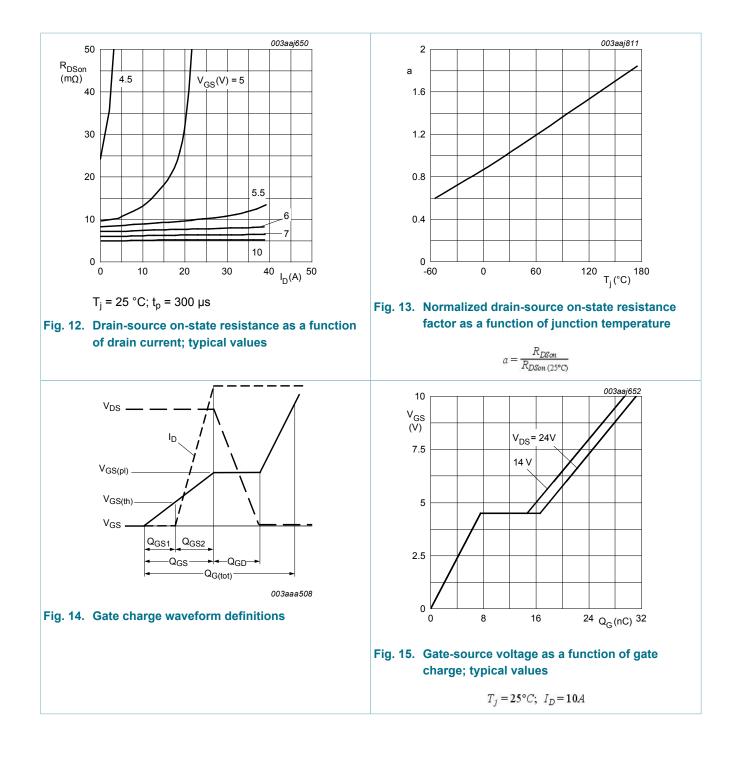
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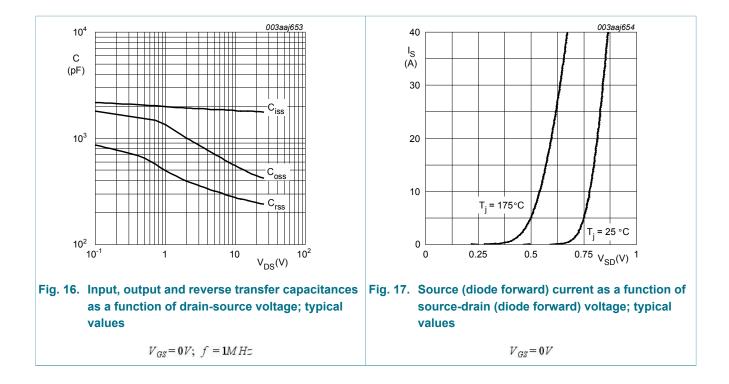
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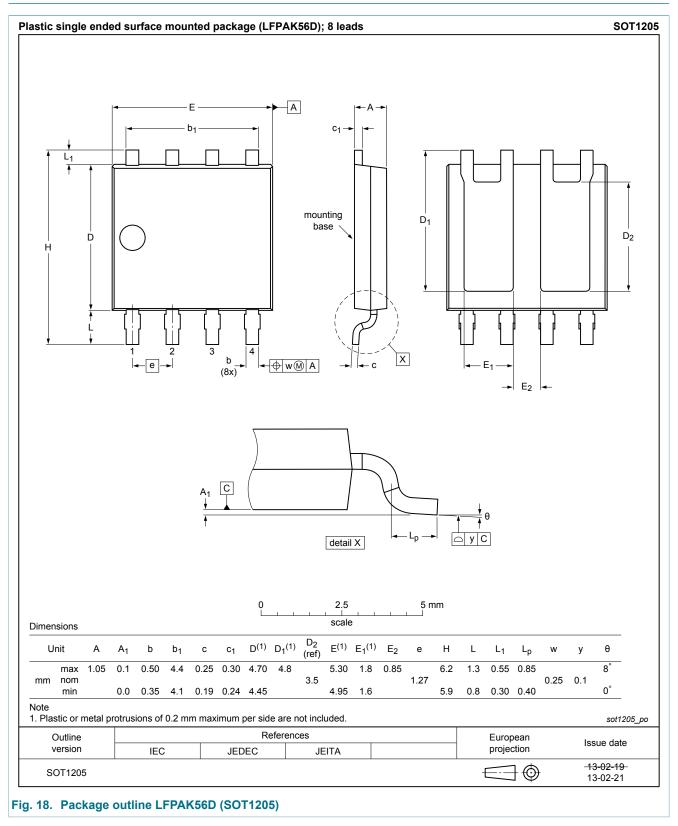
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### 11. Package outline



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### 12. Legal information

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Document status [1][2]	Product status [ <u>3]</u>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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